

An accuracy assessment of the surface reflectance product from the EMIT imaging spectrometer

URL: <https://linkinghub.elsevier.com/retrieve/pii/S0034425724004760>

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Publication: Remote Sensing of Environment

Volume / Pagination: 31 / 114450

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Source URL (retrieved on 2 Mayo 2025 - 23:24): <https://www.bsc.es/es/research-and-development/publications/accuracy-assessment-the-surface-reflectance-product-the-emit>